

Notice of References Cited

Application/Control No.

10/560,828

Applicant(s)/Patent Under
Reexamination
XIA ET AL.

Examiner

David Buttner

Art Unit

1796

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,602,599	08-2003	Toyoda et al.	428/355AC
*	B	US-2003/0134108	07-2003	Lakatosh et al.	428/343
*	C	US-5,902,678	05-1999	Konda et al.	428/345
*	D	US-5,914,283	06-1999	Yamada et al.	442/117
*	E	US-5,723,260	03-1998	Tsuji et al.	430/278.1
*	F	US-5,637,395	06-1997	Uemura et al.	428/343
*	G	US-5,326,605	07-1994	Ono et al.	428/41.2
*	H	US-4,883,855	11-1989	Stockinger, Friedrich	528/171
*	I	US-4,170,481	10-1979	Akama et al.	430/288.1
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-01270967	10-1989	JP	Ono	----
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.